Application/Control No. Applicant(s)/Patent Under Reexamination 10/087.790 TANAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2835 Lisa Lea-Edmonds **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-4,510,215 04-1985 Adam, Michel 429/99 Α US-D421,244 02-2000 Goto, Teiyu D13/103 В С US-D476,949 07-2003 Wada, Jo D13/103 D US-D448,003 09-2001 Ogasawara, Shinichi D13/103 10-1999 Ε US-D415,466 Kawa, Mitsuo D13/103 F US-5,901,035 05-1999 Foster et al. 361/683 US-6,078,496 06-2000 G Oguchi et al. 361/683 USн US-1 US-J US-Κ US-L US-Μ FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Country Name Classification MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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